Docket No.: 60188-778 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Masahiro FUKUI, et al.

Serial No.: Divisional of Appl. No.

10/085,009

Group Art Unit:

Filed: March 26, 2004

Examiner:

For: WIRING METHOD IN LAYOUT DESIGN OF SEMICONDUCTOR INTEGRATED CIRCUIT, SEMICONDUCTOR INTEGRATED CIRCUIT AND FUNCTIONAL MACRO

PRELIMINARY AMENDMENT

Mail Stop Preliminary Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Prior to examination of the above-referenced application, please amend the application as follows: